

# MOSFET – N-Channel, POWERTRENCH®

**30 V, 88 A, 2.7 mΩ**

## FDMC86012

### General Description

This device has been designed specifically to improve the efficiency of DC/DC converters. Using new techniques in MOSFET construction, the various components of gate charge and capacitance have been optimized to reduce switching losses. Low gate resistance and very low Miller charge enable excellent performance with both adaptive and fixed dead time gate drive circuits. Very low  $r_{DS(on)}$  has been maintained to provide a sub logic-level device.

### Features

- Max  $R_{DS(on)}$  = 2.7 mΩ at  $V_{GS} = 4.5$  V,  $I_D = 23$  A
- Max  $R_{DS(on)}$  = 4.7 mΩ at  $V_{GS} = 2.5$  V,  $I_D = 17.5$  A
- High Performance Technology for Extremely low  $R_{DS(on)}$
- Termination is Lead-free
- 100% UIL Tested
- Pb-Free, Halide Free and RoHS Compliant

### Applications

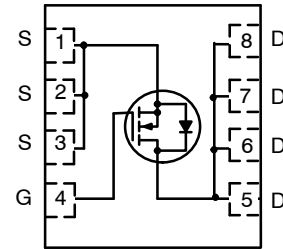
- 3.3 V Input Synchronous Buck Switch
- Synchronous Rectifier

### MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

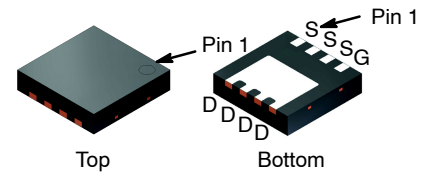
Symbol	Parameter	Value	Unit
$V_{DS}$	Drain to Source Voltage	30	V
$V_{GS}$	Gate to Source Voltage	±12	V
$I_D$	Drain Current: Continuous, $T_C = 25^\circ\text{C}$ Continuous, $T_A = 25^\circ\text{C}$ (Note 1a) Pulsed (Note 4)	88 23 230	A
$E_{AS}$	Single Pulse Avalanche Energy (Note 3)	337	mJ
$P_D$	Power Dissipation: $T_C = 25^\circ\text{C}$ $T_A = 25^\circ\text{C}$ (Note 1a)	54 2.3	W
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ\text{C}$

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

$V_{DS}$	$R_{DS(on)}$ MAX	$I_D$ MAX
30 V	2.7 mΩ @ 4.5 V	88 A
	4.7 mΩ @ 2.5 V	

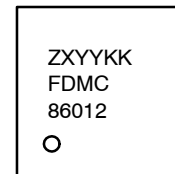


N-CHANNEL MOSFET



WDFN8 3.3 × 3.3, 0.65P  
CASE 483AW

### MARKING DIAGRAM



- Z = Assembly Plant Code
- XYY = 3-Digit Date Code Format
- KK = 2-Alphanumeric Lot Run Traceability Code
- FDMC86012 = Specific Device Code

### ORDERING INFORMATION

Device	Package	Shipping†
FDMC86012	WDFN8 (Pb-Free, Halide Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, [BRD8011/D](#).

# FDMC86012

## THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case (Note 1)	2.3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	

## ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
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### OFF CHARACTERISTICS

$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = 250 \mu\text{A}, V_{GS} = 0 \text{ V}$	30	–	–	V
$\Delta BV_{DSS} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , referenced to $25^\circ\text{C}$	–	43	–	mV/°C
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$	–	–	1	$\mu\text{A}$
$I_{GSS}$	Gate to Source Leakage Current	$V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$	–	–	$\pm 100$	nA

### ON CHARACTERISTICS

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu\text{A}$	0.8	1.0	1.5	V
$\Delta V_{GS(th)} / \Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , referenced to $25^\circ\text{C}$	–	–4	–	mV/°C
$R_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 23 \text{ A}$	–	2.2	2.7	m $\Omega$
		$V_{GS} = 2.5 \text{ V}, I_D = 17.5 \text{ A}$	–	3.4	4.7	
		$V_{GS} = 4.5 \text{ V}, I_D = 23 \text{ A}, T_J = 125^\circ\text{C}$	–	3.5	4.3	
$g_{FS}$	Forward Transconductance	$V_{DD} = 5 \text{ V}, I_D = 23 \text{ A}$	–	144	–	S

### DYNAMIC CHARACTERISTICS

$C_{iss}$	Input Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	–	3625	5075	pF
$C_{oss}$	Output Capacitance		–	1230	1725	pF
$C_{rss}$	Reverse Transfer Capacitance		–	185	260	pF
$R_g$	Gate Resistance		0.1	0.9	3.0	$\Omega$

### SWITCHING CHARACTERISTICS

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 15 \text{ V}, I_D = 23 \text{ A}, V_{GS} = 4.5 \text{ V}, R_{GEN} = 6 \Omega$	–	20	32	ns
$t_r$	Rise Time		–	11	20	ns
$t_{d(off)}$	Turn-Off Delay Time		–	43	69	ns
$t_f$	Fall Time		–	8	16	ns
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}, V_{DD} = 15 \text{ V}, I_D = 23 \text{ A}$	–	27	38	nC
		$V_{GS} = 0 \text{ V to } 2.5 \text{ V}, V_{DD} = 15 \text{ V}, I_D = 23 \text{ A}$	–	16	23	nC
$Q_{gs}$	Gate to Source Charge	$V_{DD} = 15 \text{ V}, I_D = 23 \text{ A}$	–	5.8	–	nC
$Q_{gd}$	Gate to Drain "Miller" Charge	$V_{DD} = 15 \text{ V}, I_D = 23 \text{ A}$	–	5.4	–	nC

# FDMC86012

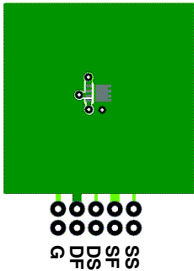
## ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$ unless otherwise noted) (continued)

Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
<b>DRAIN-SOURCE DIODE CHARACTERISTICS</b>						
$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = 23\text{ A}$ (Note 2)	–	0.8	1.3	V
		$V_{GS} = 0\text{ V}, I_S = 1.9\text{ A}$ (Note 2)	–	0.7	1.2	
$t_{rr}$	Reverse Recovery Time	$I_F = 23\text{ A}, di/dt = 100\text{ A}/\mu\text{s}$	–	40	64	ns
$Q_{rr}$	Reverse Recovery Charge		–	23	37	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

**NOTES:**

- $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a) 53°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b) 125°C/W when mounted on a minimum pad of 2 oz copper.

- Pulse Test: Pulse Width < 300  $\mu\text{s}$ , Duty cycle < 2.0%.
- $E_{AS}$  of 337 mJ is based on starting  $T_J = 25^\circ\text{C}$ ; N-ch:  $L = 3\text{ mH}, I_{AS} = 15\text{ A}, V_{DD} = 30\text{ V}, V_{GS} = 10\text{ V}$ . 100% test at  $L = 0.3\text{ mH}, I_{AS} = 33\text{ A}$ .
- Pulsed  $I_d$  limited by junction temperature,  $t_d \leq 100\ \mu\text{s}$ , please refer to SOA curve for more details.

TYPICAL CHARACTERISTICS

( $T_J = 25^\circ\text{C}$  unless otherwise noted)

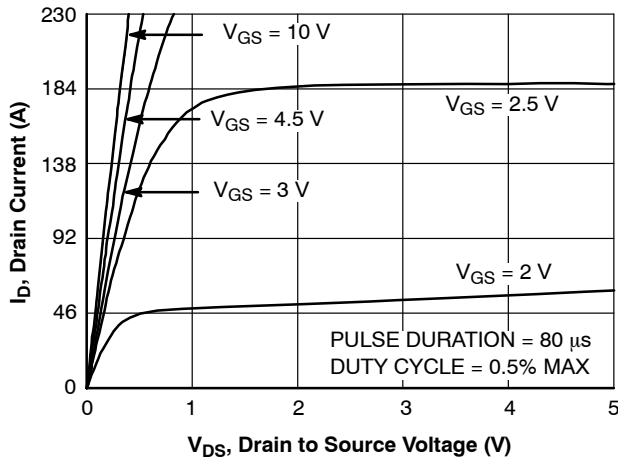


Figure 1. On-Region Characteristics

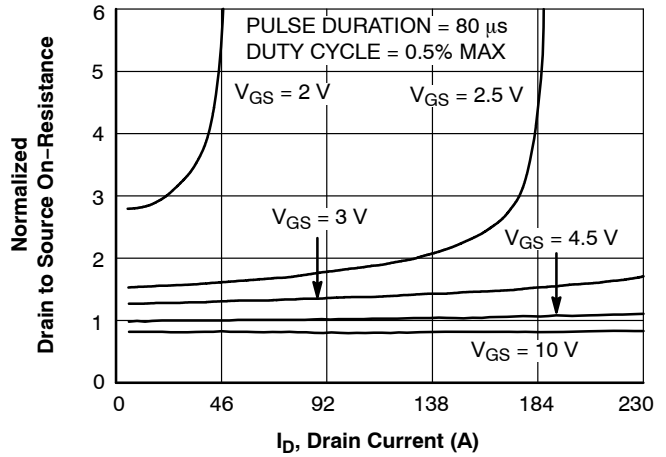


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

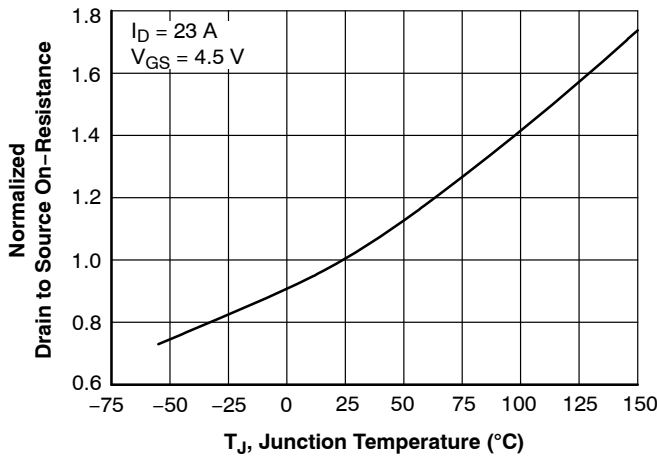


Figure 3. Normalized On-Resistance vs. Junction Temperature

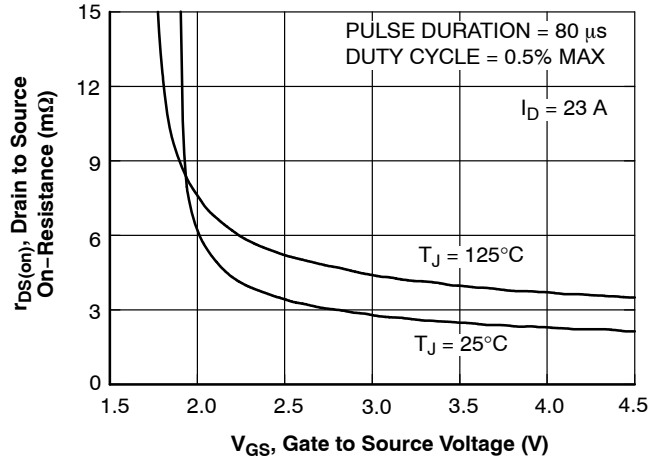


Figure 4. On-Resistance vs. Gate to Source Voltage

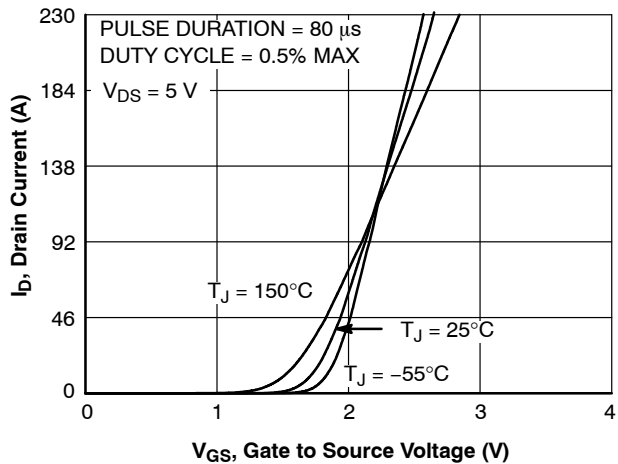


Figure 5. Transfer Characteristics

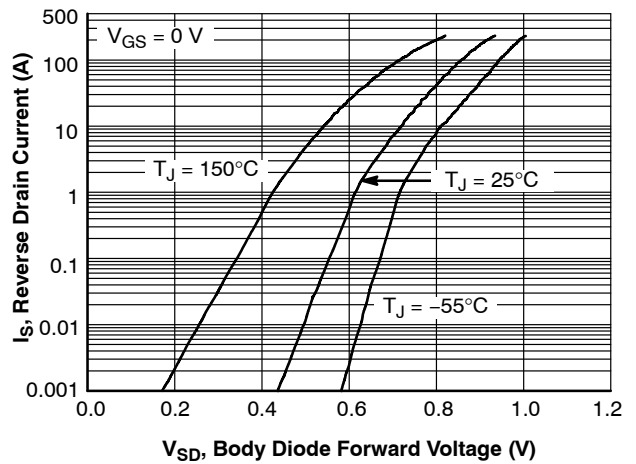


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (continued)

( $T_J = 25^\circ\text{C}$  unless otherwise noted)

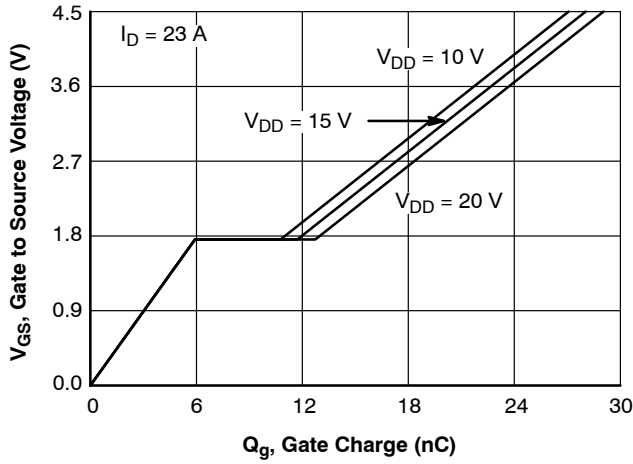


Figure 7. Gate Charge Characteristics

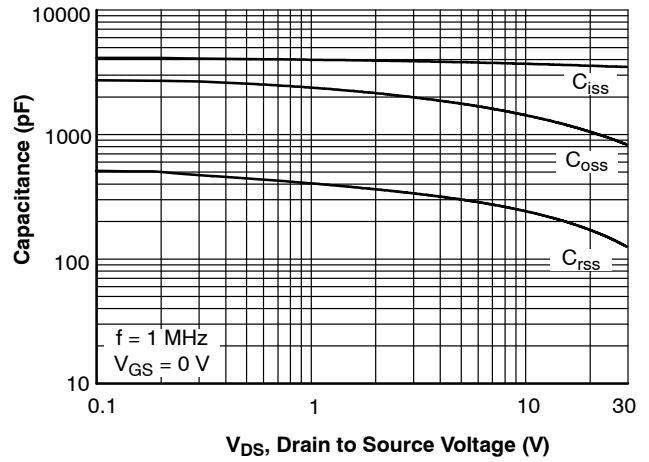


Figure 8. Capacitance vs. Drain to Source Voltage

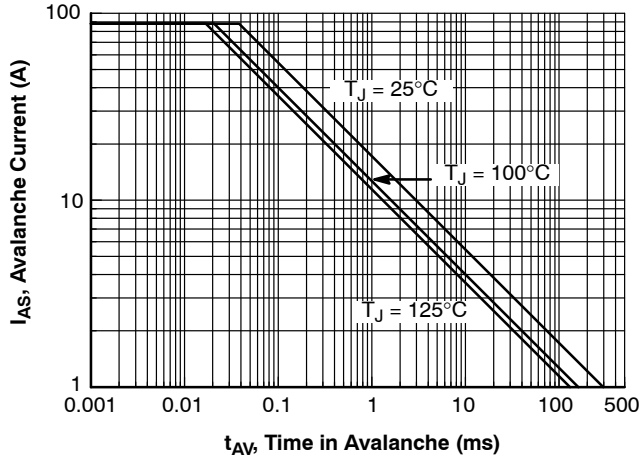


Figure 9. Unclamped Inductive Switching Capability

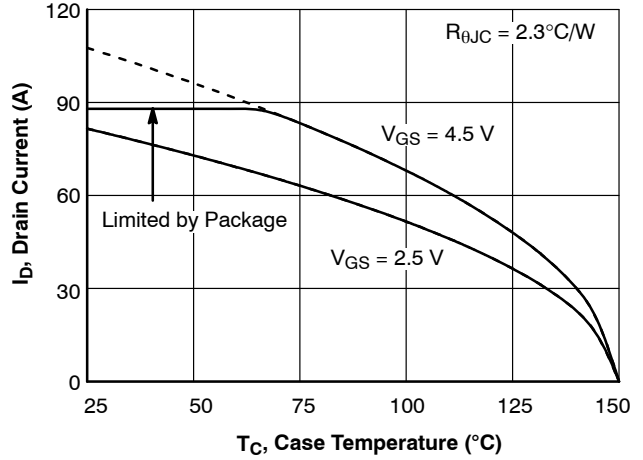


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

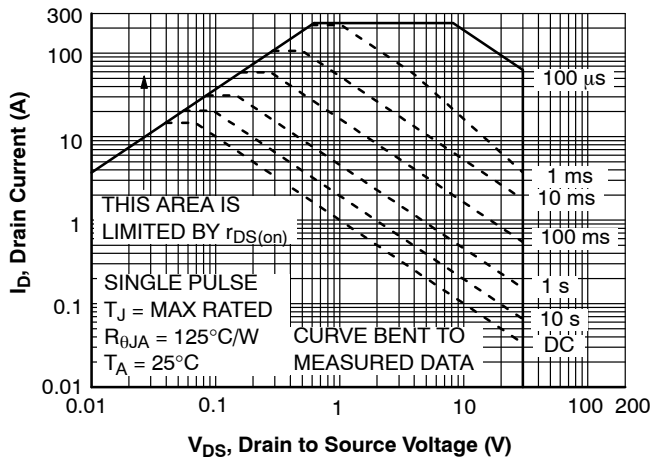


Figure 11. Forward Bias Safe Operating Area

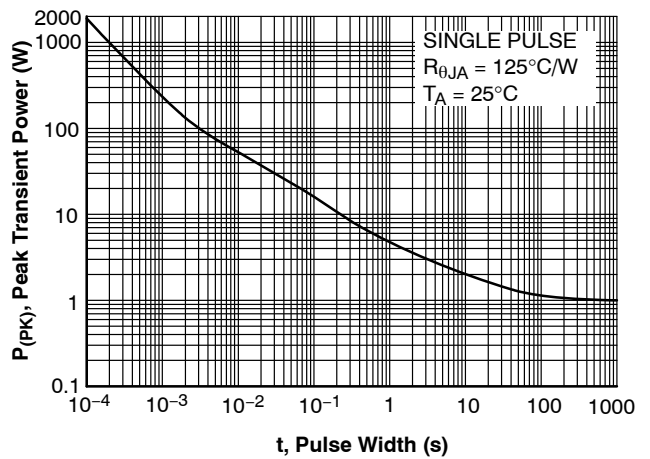


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued)

( $T_J = 25^\circ\text{C}$  unless otherwise noted)

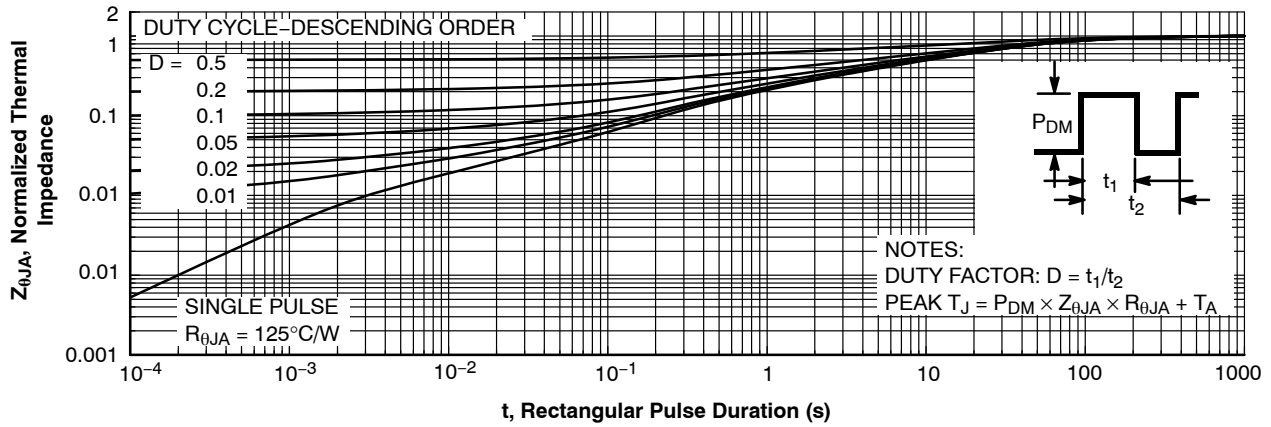
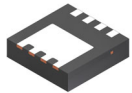
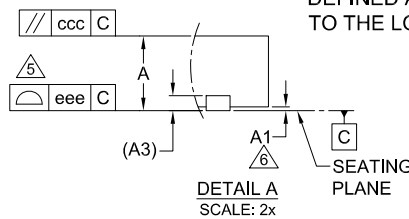
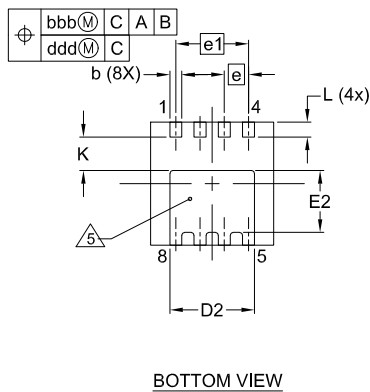
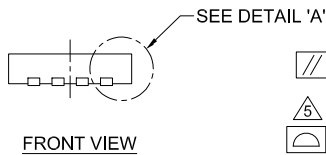
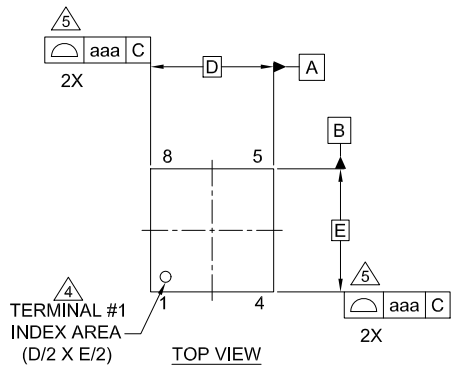


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

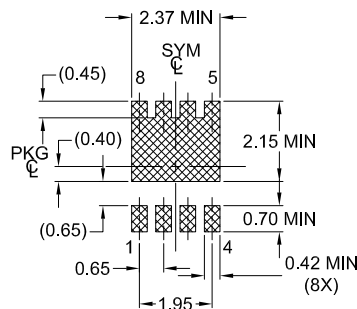


**WDFN8 3.30x3.30x0.75, 0.65P**  
**CASE 483AW**  
**ISSUE B**

DATE 22 MAR 2024



**LAND PATTERN RECOMMENDATION**



**NOTES:**

1. DIMENSIONING AND TOLERANCING CONFORM TO ASME Y14.5-2018.
2. ALL DIMENSIONS ARE IN MILLIMETERS.
3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
4. THE TERMINAL #1 IDENTIFIER AND TERMINAL NUMBERING CONVENTION SHALL CONFORM TO JEP95 SEC. 3 SPP-12. DETAILS OF TERMINAL #1 IDENTIFIER ARE OPTIONAL, BUT MUST BE LOCATED WITHIN THE ZONE INDICATED. THE TERMINAL #1 IDENTIFIER MAY BE EITHER A MOLD, EMBEDDED METAL OR MARKED FEATURE.
5. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
6. SEATING PLANE IS DEFINED BY THE TERMINALS. 'A1' IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

DIM	MILLIMETERS		
	MIN	NOM	MAX
A	0.70	0.75	0.80
A1	--	--	0.05
A3	0.20 REF		
b	0.27	0.32	0.37
D	3.30 BSC		
D2	2.17	2.27	2.37
E	3.30 BSC		
E2	1.56	1.66	1.76
e	0.65 BSC		
e1	1.95 BSC		
K	0.90	--	--
L	0.30	0.40	0.50
aaa	0.10		
bbb	0.10		
ccc	0.10		
ddd	0.05		
eee	0.05		

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

**GENERIC MARKING DIAGRAM\***



XXXX = Specific Device Code  
A = Assembly Location  
Y = Year  
WW = Work Week

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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<b>DESCRIPTION:</b>	<b>WDFN8 3.30x3.30x0.75, 0.65P</b>	<b>PAGE 1 OF 1</b>

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